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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE FEB 13 2003
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In re the Application of

Technology Center 2600

Inventors: Kenichi MIYOSHI et al. Art Unit: 2631

Application No.: 09/936,296

Filed: September 12, 2001

For: SIR MEASUREMENT APPARATUS AND SIR MEASURING METHOD

INFORMATION DISCLOSURE STATEMENT

Assistant Commissioner of Patents
Washington, DC 20231

Dear Sir:

Pursuant to Rules 56 and 99, Applicants hereby call the attention of the Patent Office to the art listed on the attached Form PTO 1449. All of these references were cited in a Supplementary European Search Report dated January 23, 2003 (copy attached).

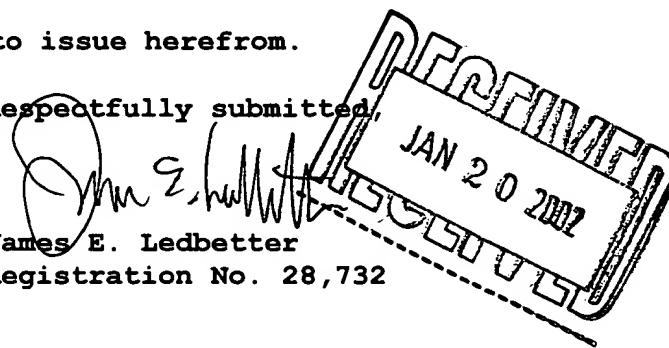
Applicants present this art so that the Patent Office may, in the first instance, determine any relevancy thereof to the presently claimed invention, see Beckman Instruments, Inc. v. Chemtronics, Inc., 439 F.2d 1369, 1380, 165 USPQ 355, 364 (5th Cir. 1970). Also see Patent Office Rules 104 and 106. Applicants respectfully request that this art be expressly considered during the prosecution of this application and made of record herein and appear among the "References Cited" on any patent to issue herefrom.

Date: February 12, 2003

JEL/spp

Respectfully submitted,

James E. Ledbetter
Registration No. 28,732



ATTORNEY DOCKET NO. L9289.01178
STEVENS, DAVIS, MILLER & MOSHER, L.L.P.
1615 L STREET, NW, Suite 850
WASHINGTON, DC 20043-4387
Telephone: (202) 785-0100
Facsimile: (202) 408-5200

<p>FORM PTO-1449 U.S. Department of Commerce (Rev. 4/92) Patent and Trademark Office</p> <p>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</p> <p>(Use several sheets if necessary)</p> <p>FEB 17 2003</p>	ATTY. DOCKET NO.	SERIAL NO.
	L9289.01178 09/936,296	
	APPLICANT	Kenichi MIYOSHI, et al.
	FILING DATE	GROUP
September 12, 2001		2631

U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

Supplementary European Search Report dated January 23, 2003.

EXAMINER _____ **DATE CONSIDERED** _____

EXAMINER: Initial if citation is considered, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.